

Notice of References Cited	Application/Control No. 10/539,949	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Kimbhinh T. Nguyen	Art Unit 2628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,741,242	05-2004	Itoh et al.	345/419
*	B	US-7,079,907	07-2006	Kimura et al.	700/98
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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